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Author(s)	Terashima, Kazuo; Kondoh, Minoru; Takamura, Yuzuru; Komaki, Hisashi; Yoshida, Toyonobu		
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Description			



## Surface modification of Bi-Sr-Ca-Cu-O films deposited in situ by radio frequency plasma flash evaporation with a scanning tunneling microscope

Kazuo Terashima, Minoru Kondoh, Yuzuru Takamura, Hisashi Komaki,<sup>a)</sup> and Toyonobu Yoshida Department of Metallurgy, Faculty of Engineering, The University of Tokyo, 7-3-1 Hongo, Bunkyo-ku, Tokyo 113, Japan

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The surface modifications of as-grown superconducting Bi-Sr-Ca-Cu-O (BSCCO) films prepared by radio frequency plasma flash evaporation were carried out with a scanning tunneling microscope (STM). The as-grown films were identified as highly *c*-axis-oriented, low  $T_c$  (80 K) phase Bi<sub>2</sub>Sr<sub>2</sub>Ca<sub>1</sub>Cu<sub>2</sub>O<sub>x</sub> with some residue such as (Sr,Ca)<sub>3</sub>Cu<sub>5</sub>O<sub>x</sub> from x-ray diffraction patterns. The as-grown film deposited at about 750 °C exhibited a superconducting critical temperature  $T_c$  of 76 K and a critical current density  $J_c$  of  $8.8 \times 10^4$  A/cm<sup>2</sup> under zero magnetic field at 27 K. The nanometer-size surface modifications between 2 and 50 nm, especially layered etching, of the prepared BSCCO films were successfully performed by using a STM in air.

Recently, nanometer-size fabrications with a scanning tunneling microscope (STM) as a powerful tool of nanotechnology<sup>1</sup> have been carried out intensively. While STM has been applied to nanometer-scale fabrications of various materials,<sup>2</sup> only surface modifications of Ho<sub>1</sub>Ba<sub>2</sub>Cu<sub>3</sub>O<sub>x</sub> films were performed among many high superconducting transition temperature  $T_c$  oxides.<sup>3</sup> An application of this technique to Bi-Sr-Ca-Cu-O (BSCCO) films is considered to be of great interest not only for engineering but also for pure science.

In this letter, we report the results of nanometer-size surface modifications of the BSCCO films deposited in situ by radio frequency (rf) plasma flash evaporation with a STM in air. An rf plasma flash evaporation has been developed and applied to the deposition of Y1Ba2Cu3Ox (YBCO) films by our group for the first time.<sup>4-7</sup> In this process, mixed fine powders of the constituents are continuously injected into a rf plasma to be coevaporated completely and codeposited onto substrates under atmospheric pressure<sup>4</sup> or a soft-vacuum environment above about 100 Torr.<sup>5,6</sup> As-grown YBCO films with high  $T_c$  (>90 K) and critical current density  $J_c$  ( > 10<sup>5</sup> A/cm<sup>2</sup> under zero magnetic field at 77 K) were successfully synthesized by this method.<sup>6</sup> Coprecipitated  $Bi_2Sr_2Ca_2Cu_3O_x$  powders of about 3  $\mu$ m in size were fed into an Ar-O<sub>2</sub> plasma, coevaporated completely, and the composition controlled hightemperature vapors were codeposited onto (100)MgO substrates placed in a plasma tail flame. The present study is the first application to BSCCO films. The typical experimental conditions are listed in Table I. Substrates were set on a rotatable sample holder in which a chromel-almel thermocouple was attached. The duration of deposition was within 20 min and the film thicknesses were about 1  $\mu$ m. After the deposition, the samples were removed from the chamber within 10 min. No extra post-annealings were carried out. The prepared films were characterized by x-ray diffraction (XRD) patterns with the Cu K $\alpha$  line,

inductively coupled plasma (ICP) chemical analysis, and scanning electron micrograph (SEM). The electrical resistivity and  $J_c$  of the films were measured by a four-probe method. Nanometer-scale modification of the as-grown film after peeling off the near-surface region with Scotch tape was performed with a commercial STM (Nanoscope II, Digital Instruments Inc.) in air. The STM was used as an electron source for nanometer-size fabrication as well as a microscope for imaging by changing bias voltage ( $V_b$ ) and/or duration of tunneling current ( $I_t$ ) as described previously.<sup>8</sup> During fabrication,  $V_b$  was raised from low voltage (<1 V), used for imaging, to several volts without a feedback loop. The probe tips employed here were mechanically shaped Pt-Ir wires.

The typical XRD pattern of the film deposited at 750 °C is shown in Fig. 1, which reveals that the film mainly consisted of highly c-axis-oriented, low  $T_c$  (80 K) phase Bi<sub>2</sub>Sr<sub>2</sub>Ca<sub>1</sub>Cu<sub>2</sub>O<sub>x</sub> with some residue such as  $(Sr,Ca)_3Cu_5O_x$ . The average chemical compositions from ICP were Bi:Sr:Ca:Cu = 1.1:1.1:1.3:2.0. Figures 2(a) and 2(b) show the examples of SEM of the surface and cleaved cross section of as-grown film prepared at 750 °C, respectively. A dense microstructure with precipitates is observed. Figure 3 represents the temperature dependence of the dc resistivity. It is found that the superconducting critical temperature  $T_0$  (onset) and  $T_c$  (zero resistance) are 110 and 76 K, respectively. While standard thermal plasma techniques such as spraying have been applied to prepare BSCCO films, the qualities of the as-grown films have been

TABL	EI.	Typical	experimental	conditions
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rf power	50 kW (4 MHz)	
Pressure	200 Torr	
Powder	$Bi_2Sr_2Ca_2Cu_3O_x$ 3 $\mu m$	
Powder feeding rate	10 mg/min	
Plasma gas flow rate (O <sub>2</sub> )	40 <i>l</i> /min	
Carrier gas flow rate (Ar)	5 <i>l</i> /min	
Substrate	(100)MgO 2 mm $\times$ 2 mm $\times$ 10 mm	
Substrate temperature	720 –770 °C	

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<sup>&</sup>lt;sup>a)</sup>JEOL Ltd., 1418 Nakagami, Akishima-shi, Tokyo 196, Japan.



FIG. 1. XRD pattern of an as-grown Bi-Sr-Ca-Cu-O film deposited on a (100)MgO substrate.

not so good. As-grown films with  $T_c$  more than 20 K could not been prepared. <sup>9</sup> The drop of resistivity at 110 K suggests that high  $T_c$  (110 K) phases, Bi<sub>2</sub>Sr<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>y</sub>, were also partially grown in this film, while most of the film demonstrated low  $T_c$  (80 K) phases, and no clear XRD peaks of high  $T_c$  phase can be observed, as shown in XRD pattern of Fig. 1. The  $J_c$  were also deduced from the voltage-current curves by using the 10  $\mu$ V/cm criterion. The value of critical current density is  $J_c = 8.8 \times 10^4$  A/cm<sup>2</sup> at 27 K without magnetic field. While, at this very early stage, our results of  $J_c$  are inferior to those achieved by other methods such as sputtering ( $J_c > 10^6$  A/cm<sup>2</sup> at 77 K),<sup>10</sup> this process has some advantages such as a simple procedure without any high-vacuum apparatus, high dep-



FIG. 2. Scanning electron micrographs of an as-grown Bi-Sr-Ca-Cu-O film deposited on a (100)MgO substrate: (a) surface and (b) cross section.



FIG. 3. Resistivity vs temperature for an as-grown Bi-Sr-Ca-Cu-O film deposited on a (100)MgO substrate.

osition rates, and adaptabilities to depositions of multicomponents systems, large-scale depositions and continuous long-time operations for practical applications, as described previously.<sup>4-7</sup> Further research is now in progress to improve the superconducting properties.

As mentioned above, nanometer-scale fabrications of these BSCCO films with a STM in air may be of great impact for science and technology. Nanometer structures between 2 and 50 nm can be fabricated on the surfaces with a STM in air. The examples are shown in Figs. 4(a), 4(b), 4(c), and 4(d). Figure 4(a) represents a STM image ( $V_{k}$ = 0.5 V and  $I_t = 1$  nA) of a flat terrace before fabrication. Figure 4(b) shows a STM image ( $V_b = 0.5$  V and  $I_t = 1$ nA) of nanometer structure of about 10 nm in diameter created on the same region as shown in Fig. 4(a) by raising from  $V_b = 0.5$  V with  $I_t = 1$  nA for imaging to  $V_b = 4.5$  V with  $I_t = 1$  nA for 1 s. Interestingly, a hole with a flat bottom with depth of about 3 nm, which corresponds to c-axis lattice parameter of low  $T_c$  phase, could also be fabricated on a terrace of the film as shown in Figs. 4(c)  $(V_b = 0.5 \text{ V and } I_t = 1 \text{ nA})$  and 4(d), which suggests the success of atomic-scaled layered etching. This layered lithography was performed in the case of layered materials.<sup>11</sup> While the mechanism of the etching is not clear, it is considered to be electron-induced chemical etching, as in the case of graphite.<sup>12</sup> The details will be published elsewhere.

In summary, as-grown superconducting BSCCO films were successfully prepared on (100)MgO substrates by an rf plasma flash evaporation for the first time. The XRD results indicate that the structure of the as-grown film was highly *c*-axis-oriented, low  $T_{c}(80)$ K) phase  $Bi_2Sr_2Ca_1Cu_2O_x$ with some residue such as  $(Sr,Ca)_3Cu_5O_x$ . The as-grown film deposited at 750 °C exhibited a  $T_c$  of 76 K and a  $J_c$  of 8.8×10<sup>4</sup> A/cm<sup>2</sup> at 27 K. We succeeded in nanometer-size surface fabrications, especially, layer etchings, of the BSCCO films with a STM in air.



FIG. 4. Scanning tunneling micrographs taken in air: (a) surface of *c*-axis-oriented Bi-Sr-Ca-Cu-O films before surface modification, (b) nanometer structure created with a STM in air on the same region as shown in (a), (c) gray scale image of Bi-Sr-Ca-Cu-O surface layeretched in air, and (d) the line trace of the cross section through the hole indicated in Fig. 4(c).

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